

Search Notes

Application/Control No.

10/717,364

Examiner

Edwin C. Holloway, III

Applicant(s)/Patent under
Reexamination

CHANG, APIN

Art Unit

2635

SEARCHED

Class	Subclass	Date	Examiner
341	176 175	6/26/2005	EH
340	5.64 5.71		
340	5.72		
340	825.69		
340	825.72		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search notes attached	6/26/2005	EH